

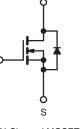
**Vishay Siliconix** 

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	800			
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	3.0		
Q <sub>g</sub> (Max.) (nC)	78			
Q <sub>gs</sub> (nC)	9.6			
Q <sub>gd</sub> (nC)	45			
Configuration	Single			

#### **TO-220 FULLPAK**





G

### N-Channel MOSFET

#### **FEATURES**

f = 60 Hz)

- Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; RoHS



COMPLIANT

- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- · Lead (Pb)-free Available

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFIBE30GPbF
	SiHFIBE30G-E3
SnPb	IRFIBE30G
	SiHFIBE30G

ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, ui	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	800	V		
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	2.1		
	VGS at 10 V	T <sub>C</sub> = 100 °C		1.4	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	8.4		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	240	mJ		
Avalanche Current <sup>a</sup>		I <sub>AR</sub>	2.1	A		
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	3.5	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		PD	35	W	
Peak Diode Recovery dV/dtc		dV/dt	2.0	V/ns		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for <sup>-</sup>	10 s		300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 102 mH,  $R_G = 25 \Omega$ ,  $I_{AS} = 2.1 \text{ A}$  (see fig. 12).

c.  $I_{SD} \leq 4.1$  A, dI/dt  $\leq 100$  A/µs,  $V_{DD} \leq 600$  V,  $T_J \leq 150$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFIBE30G, SiHFIBE30G

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THERMAL RESISTANCE RA	inas					1			
PARAMETER	SYMBOL	TYP		MAX.		UNIT			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 65			°C/W				
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 3.6				0/11			
<b>SPECIFICATIONS</b> $T_J = 25 \text{ °C}, $	unless otherv	vise noted							
PARAMETER	SYMBOL		T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT	
Static						•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 2	50 µA	800	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.90	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = 2	50 μA	2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	Ň	$V_{\rm GS} = \pm 20$	V	-	-	± 100	nA	
Zarra Oata Maltana Drain Ourrant		V <sub>DS</sub> =	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V		-	-	100		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 640 V	, V <sub>GS</sub> = 0 V	, T <sub>J</sub> = 125 °C	-	-	500	μA	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub>	= 1.3 A <sup>b</sup>	-	-	3.0	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> =	1.3 A <sup>b</sup>	1.7	-	-	S	
Dynamic		·							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V, V_{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz$		-	1300	-	pF		
Output Capacitance	C <sub>oss</sub>			-	310	-			
Reverse Transfer Capacitance	C <sub>rss</sub>			-	190	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	78		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		1 A, V <sub>DS</sub> = 400 V, e fig. 6 and 13 <sup>b</sup>	-	-	9.6	nC	
Gate-Drain Charge	Q <sub>gd</sub>		see ng		-	-	45	1	
Turn-On Delay Time	t <sub>d(on)</sub>				-	12	-		
Rise Time	t <sub>r</sub>		$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 4.1 \text{ A},$		-	33	-	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 12 Ω <sub>,</sub> R <sub>D</sub> = 95 Ω, see fig. 10 <sup>b</sup>		-	82	-	ns		
Fall Time	t <sub>f</sub>				-	30	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-			
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH		
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.1	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	8.4			
Body Diode Voltage	V <sub>SD</sub>	$T_{\rm J}$ = 25 °C, $I_{\rm S}$ = 2.1 A, $V_{\rm GS}$ = 0 V <sup>b</sup>			-	-	1.8	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 4.1 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	480	720	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.8	2.7	μC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-			-on is don	ninated by	/leandl		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.



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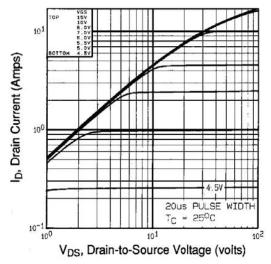
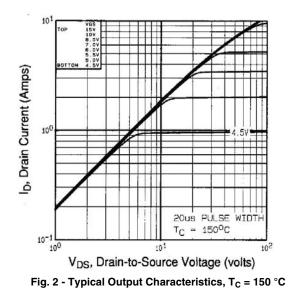
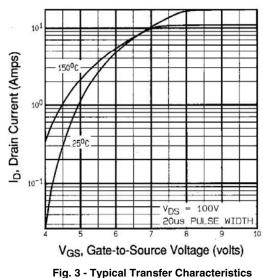


Fig. 1 - Typical Output Characteristics,  $T_C$  = 25  $^\circ C$ 





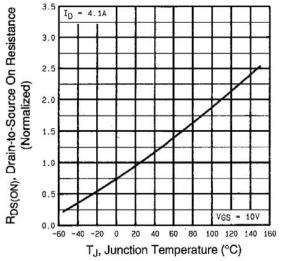


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFIBE30G, SiHFIBE30G

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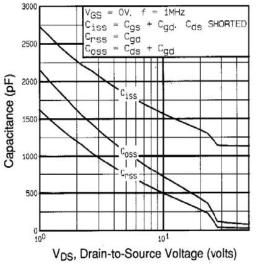


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

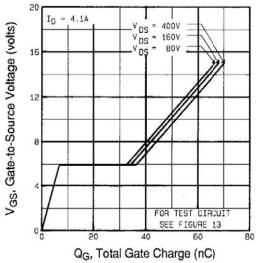
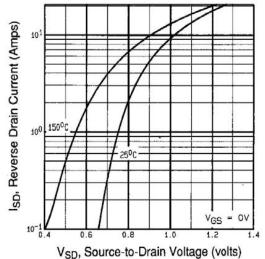
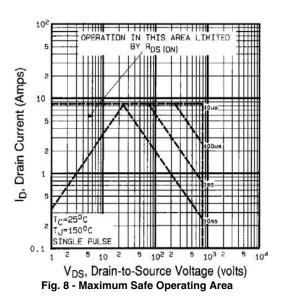


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



V<sub>SD</sub>, Source-to-Drain Voltage (volts) Fig. 7 - Typical Source-Drain Diode Forward Voltage





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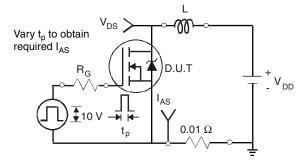


Fig. 9a - Unclamped Inductive Test Circuit

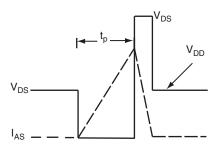
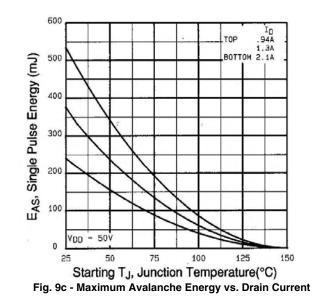
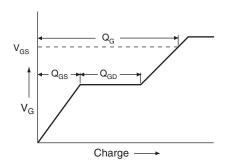


Fig. 9b - Unclamped Inductive Waveforms







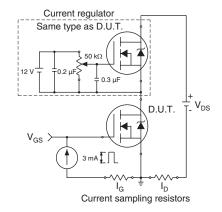
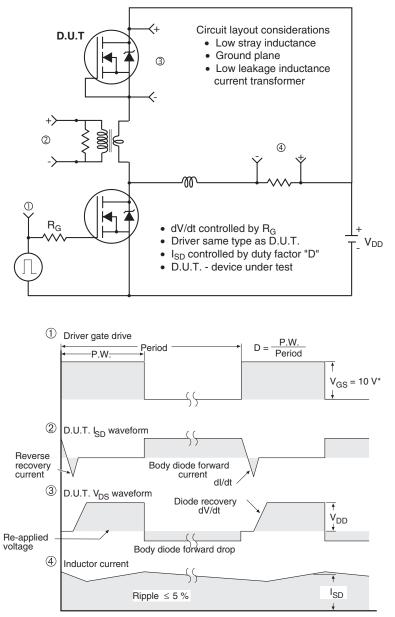


Fig. 10b - Gate Charge Test Circuit

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### Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS} = 5 V$  for logic level devices

Fig. 11 - For N-Channel

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